# **Growth and characterization of magnetite** based artificial multiferroic heterostructures



lich Centre for Neutron Science

150

T (K)

150

T (K)

200

100

100

200

250

∆T, =11.5K

250

300

300

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### Motivation

- Strain mediated magneto-elastic heterostructure device providing modulation of magnetic properties (magnetization, anisotropy, exchange bias, etc.) and spin-transport by electric field.
- Exotic properties of  $Fe_3O_4$ : half-metallic characteristics, metal-to-insulator transition (Verwey transition) at 120 K, ferrimagnetic with a Curie temperature of 850 K and multiferroicity at low temperature. Promising candidate for application in spintronics devices.



250

300

 $Fe_3O_4/PMN-PT(011)$ 

345

50

50

- Materials and Sample Preparation
- Film:  $Fe_3O_4$
- Substrate: a. MgO(001), b.  $SrTiO_3(001) \rightarrow STO(001)$ , and c.  $(0.7)[Pb(Mg_{1/3}Nb_{2/3})O_3] - (0.3)PbTiO_3(011) \rightarrow PMN-PT(011)$
- Growth Techniques: a. Oxide Molecular Beam Epitaxy (OMBE) and b. Pulsed Laser Deposition (PLD)



220

150

T (K)

100

200

References [1] Zhang et. al., APL 110, 082602 (2017). [2] Liu et. al., Scientific reports 3, 1876, (2013)

- ✤ It is still unclear if the shift of the magnetization is purely strain mediated, or if there is an influence of the PMN-PT polarization. Therefore, polarized neutron reflectometry will be used to investigate the magnetic depth profile across the heterostructure and to probe the substrate-film interface.

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